

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/088,015	VAN DER LAAN ET AL.	
	Examiner	Art Unit	Page 1 of 1
	Marcus Charles	3682	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,515,041	05-1985	Frank et al.	477/49
	B	US-4,479,356	10-1984	Gill, John D.	180/165
	C	US-4,628,773	12-1986	Itoh et al.	474/28
	D	US-4,718,306	01-1988	Shigematsu et al.	477/45
	E	US-4,790,214	12-1988	Hattori et al.	477/48
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 60-101352 A	06-1985	Japan	Nagamatsu et al.	F16H 09/18
	O	JP 06-185603 A	07-1994	Japan	Yamashita et al.	477/46
	P	DE 4331266 A1	03-1995	Germany	Schopf	F16H 61/00
	Q	EP 1099886 A	05-2001	European	Van Wilk et al.	F16H 61/00
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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